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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/801,260	03/15/2004	Ichiro Fujimori	13912US04	2251
23446	7590	01/23/2006	EXAMINER	
MCANDREWS HELD & MALLOY, LTD 500 WEST MADISON STREET SUITE 3400 CHICAGO, IL 60661			CAO, PHAT X	
			ART UNIT	PAPER NUMBER
			2814	

DATE MAILED: 01/23/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

AK

Office Action Summary

Application No.

10/801,260

Applicant(s)

FUJIMORI, ICHIRO

Examiner

Phat X. Cao

Art Unit

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 14 November 2005.
- 2a) ☒ This action is **FINAL**. 2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-15 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) _____ is/are rejected.
- 7) ☐ Claim(s) 1-15 is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|--------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date <u>10/5/05</u> | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Claim Rejections - 35 USC § 103

1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

2. Claims 1, 8-9, 12 and 14-15 are rejected under 35 U.S.C. 103(a) as being unpatentable over Puar et al (US. 6,356,497) in view of McCormack et al (US. 6,395,591).

Regarding claims 1 and 8-9, Puar (Fig. 5) discloses a system for reducing noise in a chip, the system comprising: a substrate layer (P substrate) integrated within the chip; a transistor well layer (N-Well) integrated within the chip; at least one transistor of a first transistor type (P-type) formed within the well layer; and a positive potential of a quiet voltage source Vdd (column 4, lines 59-63) that is coupled to the at least one transistor of the first transistor type.

Puar does not disclose that the transistor well layer (N-Well) is shielded by a shielding layer.

However, McCormack (Fig. 2) teaches the forming of a transistor within a transistor well layer and on a lightly doped (p-) substrate 50. The transistor well layer is shielded by a p type-shielding layer 12, which has higher doping than the (p-) substrate 50. Accordingly, it would have been obvious to modify the device of Puar by forming the shielding layer between the substrate and the transistor layer because as taught by

McCormack, the forming of a shielding layer having a higher doping than the substrate would lower the resistance of substrate for improving latchup immunity (column 1, lines 19-24) and for providing immunity against parasitic substrate effects (column 2, lines 55-59).

Regarding claims 14-15, Puar (Fig. 5) further discloses a noisy voltage source 38 of positive (column 4, lines 59-63) coupled to a source of the transistor.

Regarding claim 12, McCormack (Fig. 2) further teaches that the shielding layer 12 is disposed between the substrate layer 10 and the transistor well layer 16/18/22.

3. Claims 1-10, 12, and 14-15 are rejected under 35 U.S.C. 103(a) as being unpatentable over McCormack et al (US. 6,395,591) in view of Puar et al (US. 6,356,497).

Regarding claims 1, 8-9 and 12, McCormack (Fig. 2) discloses a system in a chip, the system comprising: a substrate layer 10 integrated within the chip; a transistor well layer 16/18/22 within the chip, which is shielded from the substrate layer 10 by a shielding layer 12; a transistor 30 of a first transistor type (P type) disposed within the transistor well layer 22, wherein the transistor well layer 22 is coupled to the shielding layer 12, and the shielding layer 12 is disposed between the substrate layer 10 and the transistor well layer 22.

McCormack does not disclose a positive potential of a quiet voltage source coupled to the transistor 30.

However, Puar (Fig. 5) teaches the forming of a system for reducing noise in a chip, the system comprising a transistor of P type disposed in a transistor well layer (N-

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Well) and having a positive potential Vdd of a quiet voltage source (column 4, lines 59-63) coupled to the transistor. Accordingly, it would have been obvious to couple a positive potential of a quiet voltage source to the transistor well layer (N-Well) of the transistor 30 of McCormack because such coupling of positive quiet voltage source to the transistor well layer would prevent the noise generated from the noisy substrate voltage, as taught by Puar (column 4, lines 55-65).

Regarding claims 2-7, McCormack (Fig. 2) further discloses a transistor 28 of a second transistor type (N type) disposed within the transistor well layer 16 and coupled to the shielding layer 12, wherein the transistor 28 has a transistor well layer 16 of P type is resistivity coupled to the shielding layer 12 of P type and has a first noisy voltage source 24 (column 3, lines 53-55) coupled to a source 17 of the transistor 28.

Regarding claim 10, McCormack (Fig. 2) further discloses that the transistor 30 has a transistor well layer 22 of N type is capacitively coupled to the shielding layer 12 of P type.

Regarding claims 14-15, Puar (Fig. 5) also teaches a noisy voltage 38 (column 4, lines 59-63) coupled to the transistor source of a first transistor type (P type).

4. Claims 11 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over McCormack et al and Puar et al as applied to claim 1 above, and further in view of Wei (US. 6,403,992).

McCormack discloses the shielding layer 12 is deep P-well, but not N-well which is capacitively coupled to the substrate layer 10.

However, Wei teaches the conventional of forming a transistor within a shielding

layer of P-well, which is capacitively coupled to the N type substrate (Fig. 3), or a transistor within a shielding layer of N-well, which is capacitively coupled to the P type substrate (Fig. 4). Accordingly, it would have been obvious to form the shielding layer 12 of McCormack with either N type or P type because they both provide the benefits of eliminating substrate effect, as taught by Wei (column 1, lines 47-60).

Response to Arguments

5. a) Applicant argues that a P type epitaxial layer 12 of McCormack does not function as a "shielding layer".

This argument is not persuasive because of the following reasons:

first, one skilled in the art would have no difficulty to recognize that the p type layer 12 would function as a shielding layer because this layer disposed between the substrate 10 and the transistor well layers for isolating the transistor well layers from the substrate 10;

second, McCormack clearly teaches the known feature of shielding the lightly doped substrate from the transistor device layer by forming the highly doped shielded layer between the lightly doped substrate and the transistor device layer for the purpose of lower the resistance of substrate to improve latch up immunity (column 1, lines 19-24). Therefore, the p type layer 12, which has higher doping than the lightly doped (p-) substrate 10, would function as a shielding layer because it shields the transistor well layers from the lightly doped substrate 10 to enhance latchup suppression (column 1, lines 19-24) and to provide immunity against parasitic substrate effects (column 2, lines 55-59 and column 6, lines 61-63); and

third, Applicant has not provide any evidences or reasons to support that the p type layer 12 would not function as an isolating layer or “shielding layer” even though it is disposed between the substrate 10 and the transistor well layers.

b) Applicant argues that the p type layer 12 of McCormack would not have properties of providing immunity against parasitic substrate effects.

This argument is not persuasive because of the following reasons:

first, as discussed in details above, McCormack clearly teaches that the p type layer 12, which has higher doping than the lightly doped (p-) substrate 10, would lower the resistance of substrate to enhance latchup suppression (column 1, lines 19-24) and would isolate the transistor well layers from the high resistant substrate to provide immunity against parasitic substrate effects (column 2, lines 55-59 and column 6, lines 61-63); and

second, it is noted that the arguments of counsel cannot take the place of evidence in the record. In re Schulze, 346 F. 2d 600, 602, 145 USPQ 716, 718 (CCPA 1965). Attorney statements are not evidence and must be supported by an appropriate affidavit or declaration. It is further noted that since the examiner has provide the burden of presenting a *prima facie* case of obviousness, the burden is shifted to Applicant to come forward with evidence which persuasively rebut the examiner's *prima facie* case of obviousness. Therefore, if Applicant belies that p type layer 12 of McCormack disposed between the lightly doped (p-) substrate and the transistor well layers would not have properties of lower the resistance of substrate for providing

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immunity against parasitic substrate effects (as taught by McCormack), then Applicant is requested to support that position with facts.

Conclusion

6. **THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire **THREE MONTHS** from the mailing date of this action. In the event a first reply is filed within **TWO MONTHS** of the mailing date of this final action and the advisory action is not mailed until after the end of the **THREE-MONTH** shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than **SIX MONTHS** from the mailing date of this final action.

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Phat X. Cao whose telephone number is 571-272-1703. The examiner can normally be reached on M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wael Fahmy can be reached on 571-272-1705. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

PC
January 20, 2006



PHAT X. CAO
PRIMARY EXAMINER